

<b>Notice of References Cited</b>	Application/Control No. 10/669,553	Applicant(s)/Patent Under Reexamination KANEKO ET AL.	
	Examiner John R. Schnurr	Art Unit 2623	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0162118 A1	10-2002	Levy et al.	725/110
*	B	US-7,120,924 B1	10-2006	Katcher et al.	725/60
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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